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# **RF Exposure Evaluation Report**

**Product** : Baby Monitor

Trade mark : VAVA

Model/Type reference : VA-IH006PU

Serial Number : N/A

Report Number : EED32L00047504 FCC ID : 2AFDGVA-IH006B

**Date of Issue** : Jul. 08, 2019

Test Standards : 47 CFR Part 1.1307

47 CFR Part 1.1310

KDB447498D01v06

Test result : PASS

#### Prepared for:

SUNVALLEYTEK INTERNATIONAL. INC 46724 lakeview Blvd, Fremont, CA 94538

Prepared by:

Centre Testing International Group Co., Ltd. Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China

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2 Version

Version No.	Date	Description
00	Jul. 08, 2019	Original
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## **General Information**

## 4.1 Client Information

Applicant:	SUNVALLEYTEK INTERNATIONAL. INC	
Address of Applicant:	46724 lakeview Blvd, Fremont, CA 94538	
Manufacturer:	Shenzhen NearbyExpress Technology Development Co., Ltd.	
Address of Manufacturer:	333 Bulong Road, jialianda Industrial Park, Building 1, Bantain, Longgang District, Shenzhen, China	
Factory:	Foshan Shunde Alford Electronics Co., Ltd	
Address of Factory:	Xinjiao Industrial Park, Daliang, Shunde Foshan City, Guangdong Province, China	

## 4.2 General Description of EUT

Product Name:	Baby Monitor		
Model No.(EUT):	VA-IH006PU		
Trade Mark:	VAVA	(6,7)	(6)
EUT Supports Radios application	2410MHz - 2477MHz		

## 4.3 Product Specification subjective to this standard

Frequency Range:	2410MHz; 2441.5MHz; 2477MHz		
Modulation Type:	GFSK		
Number of Channels:	20		
Test Power Grade:	N/A		
Test Software of EUT:	N/A		
Antenna Type:	External antenna		
Antenna Gain:	0dBi		
On advista d Danie Outroot	6.775dBm		
Conducted Peak Output Power:	The Conducted Peak Output Power data refer to the report EED32L00047503		
Sample Received Date:	Mar. 11, 2019		
Sample tested Date:	Mar. 11, 2019 to Jul. 03, 2019		
The tested sample(s) and t	he sample information are provided by the client.		
1 2 1			





















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## 4.4 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd Building C, Hongwei Industrial Park Block 70, Bao'an District, Shenzhen, China Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted. FCC Designation No.: CN1164



None.

4.6 Abnormalities from Standard Conditions

None.

4.7 Other Information Requested by the Customer

None.

















































































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### 5 SAR Evaluation

## 5.1 RF Exposure Compliance Requirement

#### 5.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06 Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

#### **5.1.2 Limits**

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]  $\sqrt{f(GHz)}$  ≤ 3.0 for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation<sup>17</sup>

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is  $\leq$  50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $\leq$  5 mm, a distance of 5 mm is applied to determine SAR test exclusion

#### 5.1.3 EUT RF Exposure

The Max Conducted Peak Output Power is 6.775dBm in lowest channel(2.410GHz);

The best case gain of the antenna is 0dBi.

EIRP=6.775dBm + 0dBi = 6.775dBm

3.504dBm logarithmic terms convert to numeric result is nearly 4.759mW

According to the formula. calculate the EIRP test result:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]  $\lceil \sqrt{f(GHz)} \rceil$ 

General RF Exposure =  $(4.759 \text{mW} / 5 \text{ mm}) \times \sqrt{2.410 \text{GHz}} = 1.477 \text{ }\bigcirc$ 

SAR requirement:

S = 3.0

1 < 2.

(2)











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# **PHOTOGRAPHS OF EUT Constructional Details**

Refer to Report No. EED32L00047503 for EUT external and internal photos.

\*\*\* End of Report \*\*\*

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